

Notice of References Cited	Application/Control No. 10/084,011	Applicant(s)/Patent Under Reexamination KACALEK ET AL.	
	Examiner Nam V. Nguyen	Art Unit 2635	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,796,024	01-1989	Sakoh et al.	340/7.58
	B	US-5,012,234	04-1991	Dulaney et al.	340/7.39
	C	US-5,193,216	03-1993	Davis, Walter L.	455/67.7
	D	US-5,320,561	06-1994	Cook et al.	439/500
	E	US-5,369,399	11-1994	Tribbey et al.	340/652
	F	US-5,705,995	01-1998	Lafin et al.	340/7.48
	G	US-5,784,001	07-1998	Deluca et al.	340/7.56
	H	US-6,020,828	02-2000	Gotou, Kazuhumi	340/7.56
	I	US-6,044,248	03-2000	Mochizuki et al.	340/7.47
	J	US-6,085,068	07-2000	Eaton et al.	340/7.22
	K	US-6,157,316	12-2000	Okayama et al.	340/7.32
	L	US-6,205,322	03-2001	Muramatsu, Toshihiko	340/7.53
	M	US-6,628,194	09-2003	Hellebust et al.	340/7.5

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.